


<b>Issue Classification</b> 	Application/Control No.		Applicant(s)/Patent under Reexamination	
	10/649,671		HIRAIWA ET AL.	
	Examiner		Art Unit	
	Hong C. Kim		2185	

ISSUE CLASSIFICATION									
ORIGINAL				CROSS REFERENCE(S)					
CLASS		SUBCLASS		CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
709		226		709	220				
INTERNATIONAL CLASSIFICATION				707	204				
60	6F	151	173	714	4				
60	6F	121	00	711	112	170	203		
			/						
			/						
			/						

_____ (Assistant Examiner) (Date)		Hong Kim 1/20/06 (Primary Examiner) (Date)		Total Claims Allowed: 7	
[Signature] (Legal Instruments Examiner) (Date)				O.G. Print Claim(s) 1 O.G. Print Fig. 1	

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant										<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original
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